



# An $\varepsilon$ -Best-Arm Identification Algorithm for Fixed-Confidence and Beyond

Marc Jourdan, Rémy Degenne and Emilie Kaufmann Univ. Lille, CNRS, Inria, Centrale Lille, UMR 9189-CRIStAL, F-59000 Lille, France



#### **Motivation**

Goal: Identify one item that has a good enough average return.

Typical approaches: control the error and minimize the sampling budget (fixed-confidence) or control the sampling budget and minimize the error (fixed-budget).

⚠ Too restrictive for many applications!

This paper: guarantees at any time on the candidate answer!

#### $\varepsilon$ -Best-arm identification ( $\varepsilon$ -BAI)

K arms:  $\nu_i \in \mathcal{D}$  is the 1-sub-Gaussian distribution of arm  $i \in [K]$  with mean  $\mu_i$ .

**Goal:** identify one of the  $\varepsilon$ -good arms  $\mathcal{I}_{\varepsilon}(\mu) = \{i \mid \mu_i \geq \mu_{\star} - \varepsilon\}$  with  $\mu^{\star} = \max_i \mu_i$ .

Algorithm: at time n,

- Recommendation rule: recommend the candidate answer  $\hat{\imath}_n$
- Sampling rule: pull arm  $I_n$  and observe  $X_n \sim \nu_{I_n}$ .

Fixed-confidence: given an error/confidence pair  $(\varepsilon, \delta) \in \mathbb{R}_+ \times (0, 1)$ , define a stopping time  $\tau_{\varepsilon, \delta}$  which is  $(\varepsilon, \delta)$ -PAC, i.e.  $\mathbb{P}_{\nu}(\tau_{\varepsilon, \delta} < +\infty, \hat{\imath}_{\tau_{\varepsilon, \delta}} \notin \mathcal{I}_{\varepsilon}(\mu)) \leq \delta$ , and

Minimize the expected sample complexity  $\mathbb{E}_{\nu}[\tau_{\varepsilon,\delta}]$ .

**Fixed-budget:** given an error/budget pair  $(\varepsilon, T) \in \mathbb{R}_+ \times \mathbb{N}$ ,

Minimize the **probablity of**  $\varepsilon$ -error  $\mathbb{P}_{\nu}(\hat{\imath}_T \notin \mathcal{I}_{\varepsilon}(\mu))$  at time T.

Anytime: Minimize the expected simple regret  $\mathbb{E}_{\nu}[\mu^{\star} - \mu_{\hat{\imath}_n}]$  at any time n.

#### Lower bound on the expected sample complexity

- ? What is the best one could achieve?
- Degenne and Koolen (2019): For all  $(\varepsilon, \delta)$ -PAC algorithms and all Gaussian instances with  $\mu \in \mathbb{R}^K$ ,  $\liminf_{\delta \to 0} \mathbb{E}_{\nu}[\tau_{\varepsilon, \delta}]/\log(1/\delta) \geq T_{\varepsilon}(\mu)$  where

$$T_{\varepsilon}(\mu) = \min_{i \in \mathcal{I}_{\varepsilon}(\mu)} \min_{\beta \in (0,1)} T_{\varepsilon,\beta}(\mu,i) \quad \text{and} \quad T_{\varepsilon,\beta}(\mu,i)^{-1} = \max_{w \in \triangle_K, w_i = \beta} \min_{j \neq i} \frac{1}{2} \frac{(\mu_i - \mu_j + \varepsilon)^2}{1/\beta + 1/w_j} \ .$$

#### Top Two sampling rule: EB-TC<sub> $\varepsilon_0$ </sub> with fixed $\beta$ or IDS proportions

**Input:** slack  $\varepsilon_0 > 0$ , proportion  $\beta \in (0,1)$  (only for fixed proportions).

Set 
$$\hat{\imath}_n \in \arg\max_{i \in [K]} \mu_{n,i}$$
,  $B_n = \hat{\imath}_n$  and  $C_n \in \arg\max_{i \neq B_n} \frac{\mu_{n,B_n} - \mu_{n,i} + \varepsilon_0}{\sqrt{1/N_{n,B_n} + 1/N_{n,i}}}$ ;

Set [fixed]  $\bar{\beta}_{n+1}(i,j) = \beta$  or [IDS]  $\beta_n(i,j) = N_{n,j}/(N_{n,i}+N_{n,j})$  and update  $\bar{\beta}_{n+1}(i,j)$ ;

Set  $I_n = C_n$  if  $N_{n,C_n}^{B_n} \le (1 - \bar{\beta}_{n+1}(B_n, C_n))T_{n+1}(B_n, C_n)$ , otherwise set  $I_n = B_n$ ;

**Output**: next arm to sample  $I_n$  and next recommendation  $\hat{\imath}_n$ .

**Notation:**  $N_{n,i} = \sum_{t \in [n-1]} \mathbb{1}(I_t = i), \ \mu_{n,i} = \sum_{t \in [n-1]} X_t \mathbb{1}(I_t = i) / N_{n,i}, \ T_n(i,j) = \sum_{t \in [n-1]} \mathbb{1}((B_t, C_t) = (i,j)), \ \bar{\beta}_n(i,j) = \sum_{t \in [n-1]} \beta_t(i,j) \mathbb{1}((B_t, C_t) = (i,j)) / T_n(i,j), \ N_{n,j}^i = \sum_{t \in [n-1]} \mathbb{1}((B_t, C_t, I_t) = (i,j,j)) \text{ and } T_n(i) = \sum_{j \neq i} (T_n(i,j) + T_n(j,i)).$ 

### $(\varepsilon, \delta)$ -PAC sequential test

- ? How to obtain a  $(\varepsilon, \delta)$ -PAC sequential test for 1-sub-Gaussian distributions ?
- **GLR**<sub> $\varepsilon$ </sub> stopping rule: recommend  $\hat{\imath}_n \in \arg\max_{i \in [K]} \mu_{n,i}$  and stop at time

$$\tau_{\varepsilon,\delta} = \inf \left\{ n > K \mid \min_{i \neq \hat{\imath}_n} \frac{\mu_{n,\hat{\imath}_n} - \mu_{n,i} + \varepsilon}{\sqrt{1/N_{n,\hat{\imath}_n} + 1/N_{n,i}}} \ge \sqrt{2c(n-1,\delta)} \right\} , \tag{1}$$

with  $c(n, \delta) = 2\mathcal{C}_G(\log((K-1)/\delta)/2) + 4\log(4 + \log(n/2))$  and  $\mathcal{C}_G(x) \approx x + \ln(x)$ .

#### Asymptotic fixed-confidence guarantees

**Theorem 1.** Let  $\varepsilon \geq 0$  and  $\varepsilon_0 > 0$ . Combined with  $GLR_{\varepsilon}$  stopping (1), the EB- $TC_{\varepsilon_0}$  algorithm satisfies that, for all  $\nu \in \mathcal{D}^K$  with mean  $\mu$  such that  $|i^{\star}(\mu)| = 1$ ,

- IDS:  $\limsup_{\delta \to 0} \mathbb{E}_{\nu}[\tau_{\varepsilon,\delta}]/\log(1/\delta) \leq T_{\varepsilon_0}(\mu)D_{\varepsilon,\varepsilon_0}(\mu)$ ,
- fixed  $\beta \in (0,1)$ :  $\limsup_{\delta \to 0} \mathbb{E}_{\nu}[\tau_{\varepsilon,\delta}]/\log(1/\delta) \leq T_{\varepsilon_0,\beta}(\mu)D_{\varepsilon,\varepsilon_0}(\mu)$ ,

where  $D_{\varepsilon,\varepsilon_0}(\mu) = (1 + \max_{i \neq i^*} (\varepsilon_0 - \varepsilon)/(\mu_* - \mu_i + \varepsilon))^2$ .

**Corollary 1.** Let  $\varepsilon > 0$ . Combined with GLR $_{\varepsilon}$  stopping (1), the EB-TC $_{\varepsilon}$  algorithm with IDS (resp. fixed  $\beta$ ) proportions is **asymptotically** (resp.  $\beta$ -)**optimal** in fixed-confidence  $\varepsilon$ -BAI for Gaussian distributions.

#### Finite fixed-confidence guarantees

**Theorem 2.** Let  $\delta \in (0,1)$  and  $\varepsilon_0 > 0$ . Combined with  $GLR_{\varepsilon_0}$  stopping (1), the EB- $TC_{\varepsilon_0}$  algorithm with fixed  $\beta = 1/2$  satisfies that, for all  $\nu \in \mathcal{D}^K$  with mean  $\mu$ ,

$$\mathbb{E}_{\nu}[\tau_{\varepsilon_0,\delta}] \leq \inf_{\varepsilon \in [0,\varepsilon_0]} \max \left\{ T_{\mu,\varepsilon_0}(\delta,\varepsilon) + 1, \ S_{\mu,\varepsilon_0}(\varepsilon) \right\} + 2K^2 \ , \quad \textit{where}$$

 $\limsup_{\delta \to 0} \frac{T_{\mu,\varepsilon_0}(\delta,0)}{\log(1/\delta)} \leq 2|i^\star(\mu)|T_{\varepsilon_0,1/2}(\mu) \text{ and } S_{\mu,\varepsilon_0}(\varepsilon_0/2) = \mathcal{O}(K^2|\mathcal{I}_{\varepsilon_0/2}(\mu)|\varepsilon_0^{-2}\log\varepsilon_0^{-1}).$ 

#### **Key technical tool**

**Lemma 1.** Let  $\delta \in (0,1]$  and n > K. Assume there exists a sequence of events  $(A_t(n,\delta))_{n \geq t > K}$  and positive reals  $(D_i(n,\delta))_{i \in [K]}$  such that, for all  $t \in \{K+1,\ldots,n\}$ , under the event  $A_t(n,\delta)$ , there exists  $i_t \in \{B_t,C_t\}$ , such that  $T_t(i_t) \leq D_{i_t}(n,\delta)$ . Then, we have  $\sum_{t=K+1}^n \mathbbm{1}(A_t(n,\delta)) \leq \sum_{i \in [K]} D_i(n,\delta)$ .

#### **Beyond fixed-confidence guarantees**

Anytime guarantees on the probability of  $\varepsilon$ -error and the expected simple regret.

**Theorem 3.** Let  $\varepsilon_0 > 0$  and  $p(x) = x - \log x$ . The EB-TC<sub> $\varepsilon_0$ </sub> algorithm with fixed proportions  $\beta = 1/2$  satisfies that, for all  $\nu \in \mathcal{D}^K$  with mean  $\mu$ , for all  $n > 5K^2/2$ ,

$$\forall \varepsilon \ge 0, \quad \mathbb{P}_{\nu} \left( \hat{\imath}_n \notin \mathcal{I}_{\varepsilon}(\mu) \right) \le K^2 e^2 (2 + \log n)^2 \exp \left( -p \left( \frac{n - 5K^2/2}{8H_{i_{\nu}(\varepsilon)}(\mu, \varepsilon_0)} \right) \right),$$

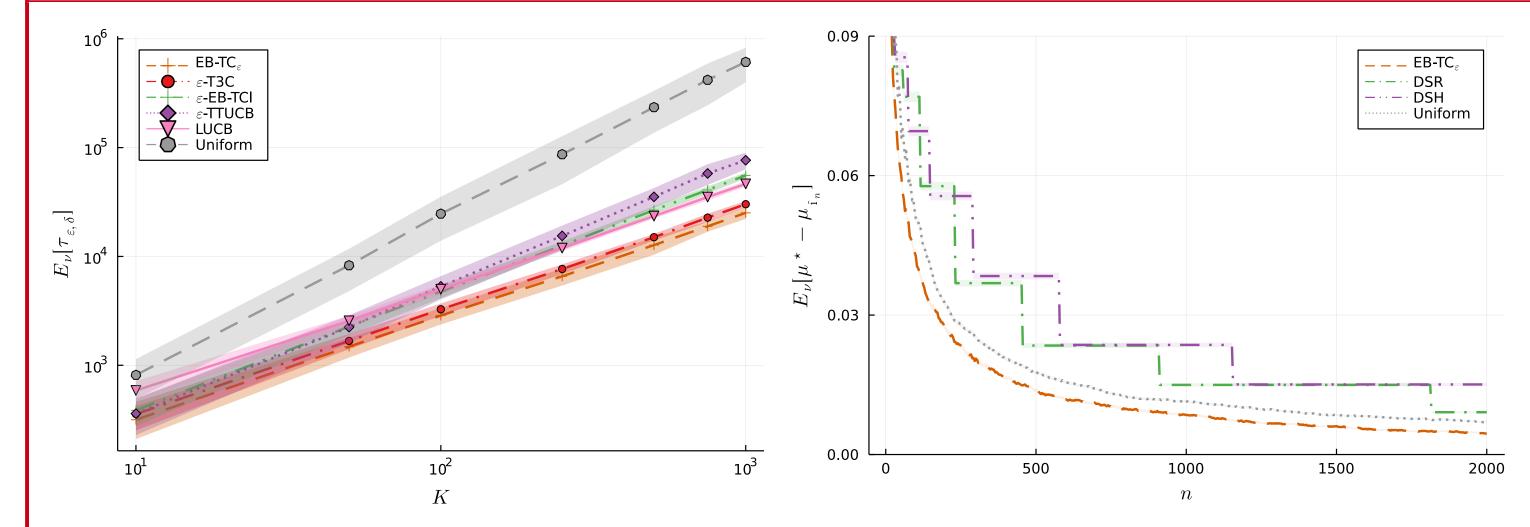
$$\mathbb{E}_{\nu}[\mu_{\star} - \mu_{\hat{\imath}_n}] \le K^2 e^2 (2 + \log n)^2 \sum_{i \in [C_{\mu} - 1]} (\Delta_{i+1} - \Delta_i) \exp\left(-p\left(\frac{n - 5K^2/2}{8H_i(\mu, \varepsilon_0)}\right)\right) ,$$

where  $(H_i(\mu, \varepsilon_0))_{i \in [C_\mu - 1]}$  are such that  $H_1(\mu, \varepsilon_0) = K(2\Delta_{\min}^{-1} + 3\varepsilon_0^{-1})^2$  and  $K/\Delta_{i+1}^{-2} \le H_i(\mu, \varepsilon_0) \le K \min_{j \in [i]} \max\{2\Delta_{j+1}^{-1}, \ 2\frac{\Delta_j/\varepsilon_0 + 1}{\Delta_{i+1} - \Delta_j} + 3\varepsilon_0^{-1}\}^2$  for all i > 1.

Notation: distinct mean gaps  $0=\Delta_1<\Delta_2<\cdots<\Delta_{C_{\mu}}<\Delta_{C_{\mu}}<\Delta_{C_{\mu}+1}=+\infty$  where  $C_{\mu}=|\{\mu_i\mid i\in [K]\}|$ . For all  $\varepsilon\geq 0$ , let  $i_{\mu}(\varepsilon)=i$  if  $\varepsilon\in [\Delta_i,\Delta_{i+1})$ .

Other guarantees: unverifiable sample complexity and cumulative regret.

## Experiments



**Figure 1:** (a) Stopping time on instances  $\mu_i=1-((i-1)/(K-1))^{0.3}$  for varying K. (b) Simple regret on instance  $\mu=(0.6,0.6,0.55,0.45,0.3,0.2)$  fors EB-TC $_{\varepsilon_0}$  with slack  $\varepsilon_0=0.1$  and fixed  $\beta=1/2$ .

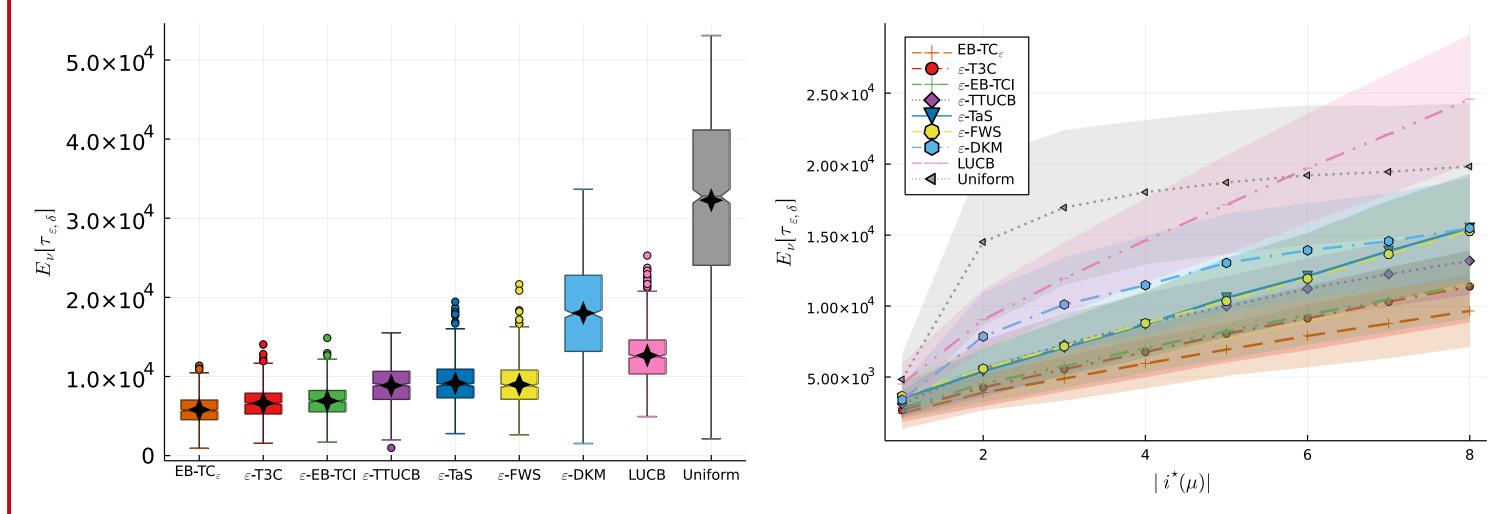


Figure 2: Stopping time on (a) random instances (K=20) with  $\mu_1=1$ ,  $\mu_i\sim\mathcal{U}([0,0.9)$  for all  $i\geq 6$ , otherwise  $\mu_i\sim\mathcal{U}([0.9,1])$  and (b) "two-groups" instances (K=10) with  $(\mu^\star,\Delta_2)=(0.6,0.2)$ .

*Note:* GLR<sub> $\varepsilon$ </sub> stopping (1) with  $(\varepsilon, \delta) = (10^{-1}, 10^{-2})$ . T3C, EB-TCI, TTUCB, TaS, FWS, DKM are modified for  $\varepsilon$ -BAI.

#### Conclusion

- 1. Good empirical performance as regards the sample complexity and the simple regret. Easy to implement and computationally inexpensive algorithm.
- 2. Asymptotic and finite confidence upper bound on the expected sample complexity. Asymptotic ( $\beta$ -)optimality in  $\varepsilon$ -BAI for Gaussian distributions.
- 3. Anytime upper bounds on the uniform  $\varepsilon$ -error and the expected simple regret.